## Application/Control No. Applicant(s)/Patent Under Reexamination 10/050,135 NAKAMATSU ET AL Notice of References Cited Examiner Art Unit Page 1 of 1 Debra F. Charles 3624 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,542,593 B1 04-2003 Bowman-Amuah, Michel K. 379/201.03 US-В US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S

**NON-PATENT DOCUMENTS** 

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